# NCE0224AF-VB Datasheet

## N-Channel 200-V (D-S) MOSFET

| PRODUCT SUMMARY | | | |
|---|---|---|---|
| $V_{(BR)DSS}$ (V) | $R_{DS(on)}$ (Ω) | $I_D$ (A) | $Q_g$ (Typ.) |
| 200 | 0.038 at $V_{GS}$ = 15 V | 45 | 57 |
| | 0.043 at $V_{GS}$ = 10 V | 40 | |

### FEATURES

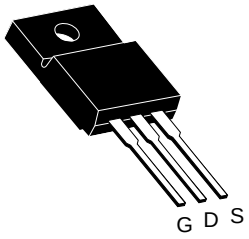
- Trench Power MOSFETS
- 175 °C Junction Temperature
- 100 % $R_g$ and UIS Tested

RoHS COMPLIANT

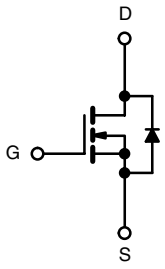
### APPLICATIONS

- Power Supply
- Lighting Systems

**TO-220 FULLPAK**




Top View




N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS $T_A$ = 25 °C, unless otherwise noted | | | | |
|---|---|---|---|---|
| **Parameter** | | **Symbol** | **Limit** | **Unit** |
| Drain-Source Voltage | | $V_{DS}$ | 200 | V |
| Gate-Source Voltage | | $V_{GS}$ | ± 25 | |
| Continuous Drain Current ($T_J$ = 175 °C) | $T_C$ = 25 °C | $I_D$ | 45 | A |
| | $T_C$ = 100 °C | | 26 | |
| Pulsed Drain Current | | $I_{DM}$ | 150 | |
| Single Pulse Avalanche Current | L = 0.1 mH | $I_{AS}$ | 20 | |
| Single Pulse Avalanche Energy[a] | | $E_{AS}$ | 20 | mJ |
| Maximum Power Dissipation[a] | $T_C$ = 25 °C | $P_D$ | 55[b] | W |
| | $T_A$ = 25 °C[c] | | 3.12 | |
| Operating Junction and Storage Temperature Range | | $T_J$, $T_{stg}$ | - 55 to 175 | °C |

| THERMAL RESISTANCE RATINGS | | | |
|---|---|---|---|
| **Parameter** | **Symbol** | **Limit** | **Unit** |
| Junction-to-Ambient (PCB Mount)[c] | $R_{thJA}$ | 40 | °C/W |
| Junction-to-Case (Drain) | $R_{thJC}$ | 0.75 | |

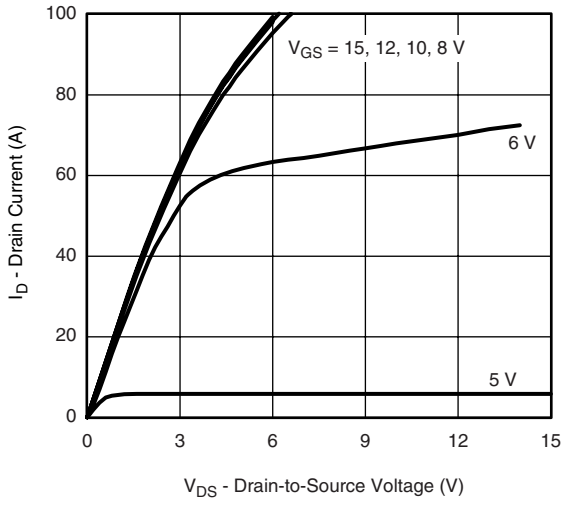
Notes:
a. Duty cycle ≤ 1 %.
b. See SOA curve for voltage derating.
c. When Mounted on 1" square PCB (FR-4 material).

| **SPECIFICATIONS** ($T_J$ = 25 °C, unless otherwise noted) | | | | | | |
|---|---|---|---|---|---|---|
| **Parameter** | **Symbol** | **Test Conditions** | **Min.** | **Typ.[a]** | **Max.** | **Unit** |
| **Static** | | | | | | |
| Drain-Source Breakdown Voltage | $V_{DS}$ | $V_{GS}$ = 0 V, $I_D$ = 250 µA | 200 | | | V |
| Gate Threshold Voltage | $V_{GS(th)}$ | $V_{DS}$ = $V_{GS}$, $I_D$ = 250 µA | 2 | | 4 | |
| Gate-Body Leakage | $I_{GSS}$ | $V_{DS}$ = 0 V, $V_{GS}$ = ± 20 V | | | ± 100 | nA |
| Zero Gate Voltage Drain Current | $I_{DSS}$ | $V_{DS}$ = 200 V, $V_{GS}$ = 0 V | | | 1 | µA |
| | | $V_{DS}$ = 200 V, $V_{GS}$ = 0 V, $T_J$ = 125 °C | | | 50 | |
| | | $V_{DS}$ = 200 V, $V_{GS}$ = 0 V, $T_J$ = 175 °C | | | 250 | |
| On-State Drain Current[b] | $I_{D(on)}$ | $V_{DS}$ = 5 V, $V_{GS}$ = 10 V | 40 | | | A |
| Drain-Source On-State Resistance[b] | $R_{DS(on)}$ | $V_{GS}$ = 10 V, $I_D$ = 3 A | | 0.048 | | Ω |
| | | $V_{GS}$ = 10 V, $I_D$ = 3 A, $T_J$ = 125 °C | | 0.050 | | |
| | | $V_{GS}$ = 10 V, $I_D$ = 3 A, $T_J$ = 175 °C | | 0.070 | | |
| | | $V_{GS}$ = 6 V, $I_D$ = 3 A | | 0.092 | | |
| Forward Transconductance[b] | $g_{fs}$ | $V_{DS}$ = 15 V, $I_D$ = 3 A | | 35 | | S |
| **Dynamic[a]** | | | | | | |
| Input Capacitance | $C_{iss}$ | $V_{GS}$ = 0 V, $V_{DS}$ = 25 V, F = 1 MHz | | 2800 | | pF |
| Output Capacitance | $C_{oss}$ | | | 180 | | |
| Reverse Transfer Capacitance | $C_{rss}$ | | | 80 | | |
| Total Gate Charge[c] | $Q_g$ | $V_{DS}$ = 100 V, $V_{GS}$ = 10 V, $I_D$ = 3 A | | 34 | 51 | nC |
| Gate-Source Charge[c] | $Q_{gs}$ | | | 8 | | |
| Gate-Drain Charge[c] | $Q_{gd}$ | | | 12 | | |
| Gate Resistance | $R_g$ | | 0.5 | | 2.9 | Ω |
| Turn-On Delay Time[c] | $t_{d(on)}$ | $V_{DD}$ = 100 V, $R_L$ = 5.2 Ω<br>$I_D$ ≅ 3 A, $V_{GEN}$ = 10 V, $R_g$ = 2.5 Ω | | 15 | 25 | ns |
| Rise Time[c] | $t_r$ | | | 50 | 75 | |
| Turn-Off Delay Time[c] | $t_{d(off)}$ | | | 30 | 45 | |
| Fall Time[c] | $t_f$ | | | 60 | 90 | |
| **Source-Drain Diode Ratings and Characteristics** ($T_C$ = 25 °C) | | | | | | |
| Pulsed Current | $I_{SM}$ | | | | 30 | A |
| Diode Forward Voltage[b] | $V_{SD}$ | $I_F$ = 3 A, $V_{GS}$ = 0 V | | 0.9 | 1.5 | V |
| Source-Drain Reverse Recovery Time | $t_{rr}$ | $I_F$ = 3 A, dI/dt = 100 A/µs | | 180 | 250 | ns |

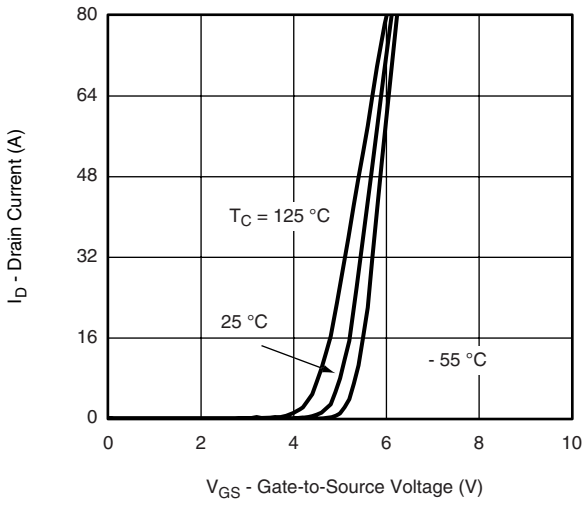
Notes:
a. Guaranteed by design, not subject to production testing.
b. Pulse test; pulse width ≤ 300 µs, duty cycle ≤ 2 %.
c. Independent of operating temperature.

*Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.*

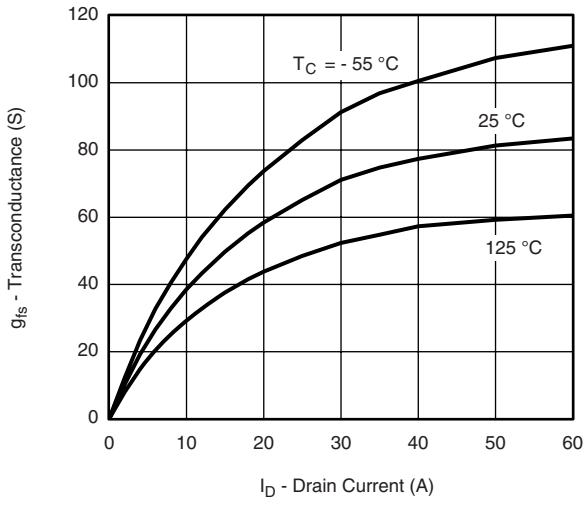
## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



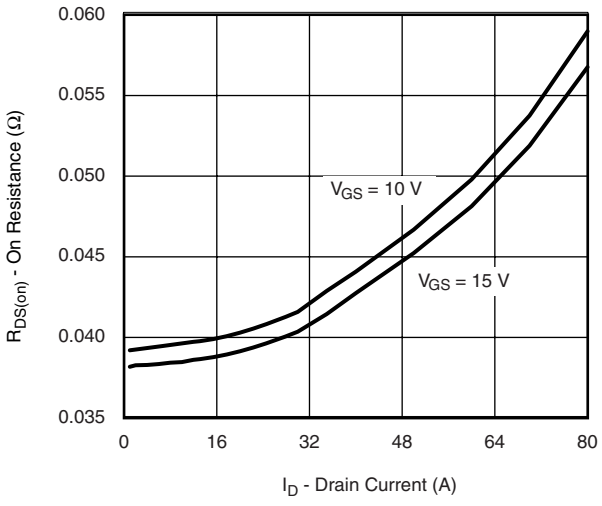

**Output Characteristics**



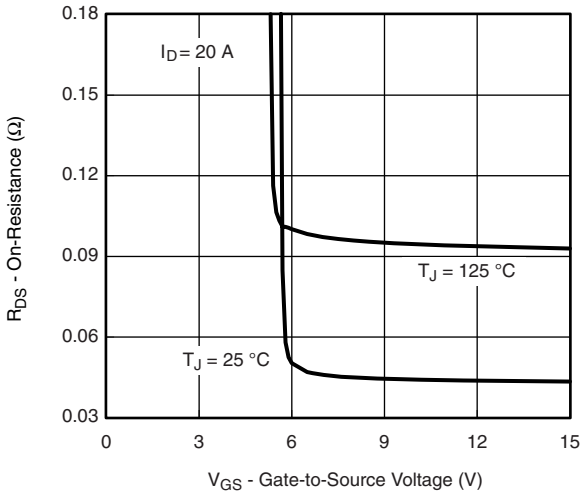

**Transfer Characteristics**



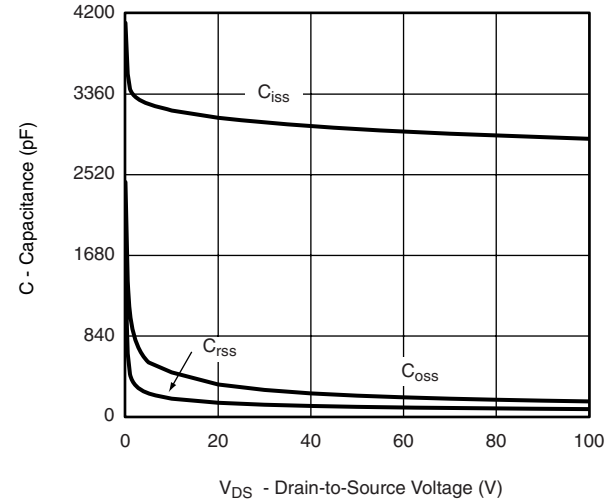

**Transconductance**




**On-Resistance vs. Drain Current**

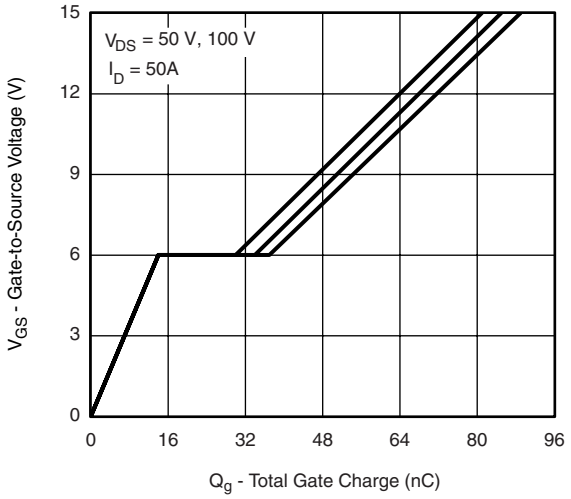



**On-Resistance vs. Gate-to-Source Voltage**

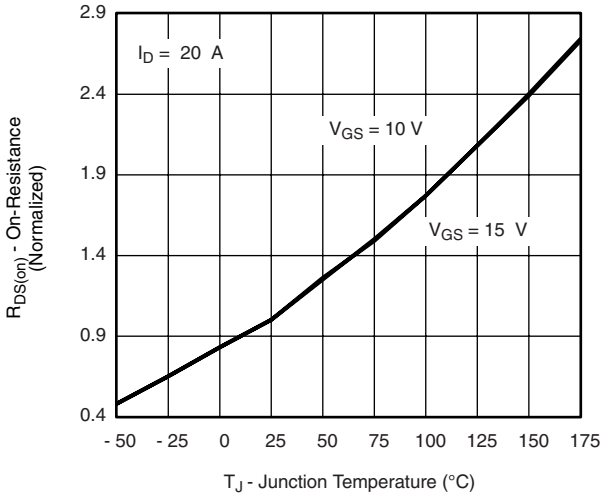



**Capacitance**

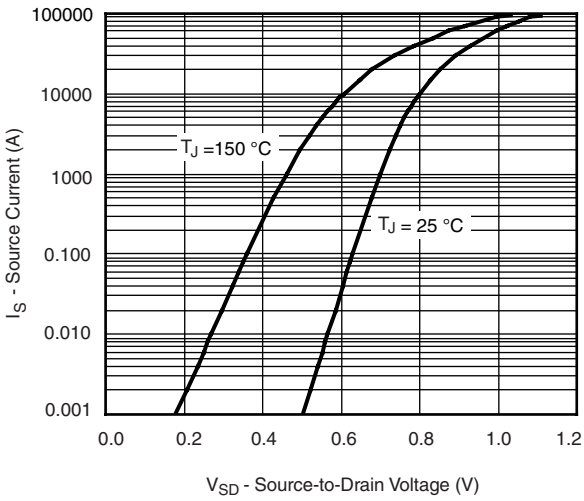
## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



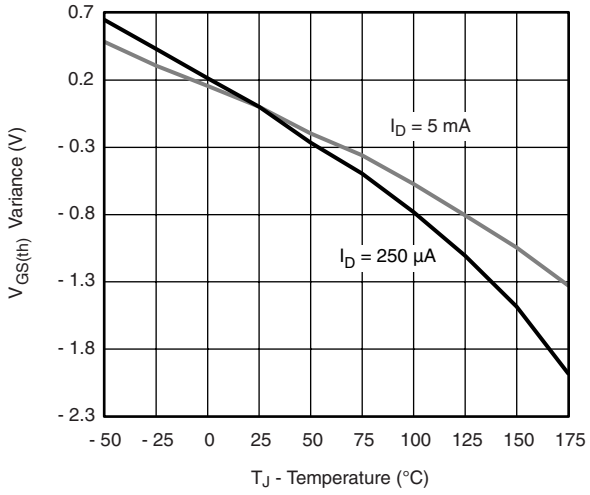

**Gate Charge**



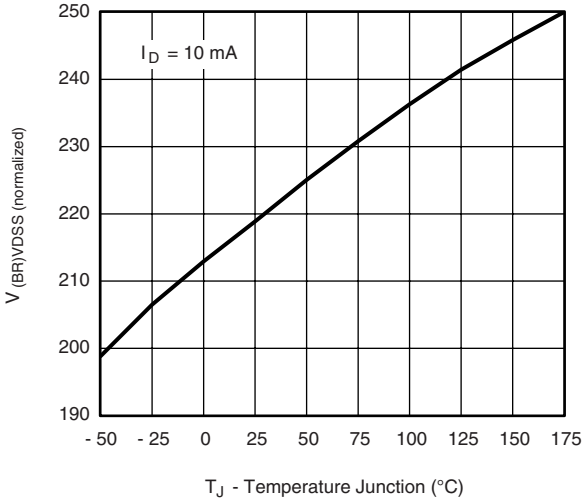

**On-Resistance vs. Junction Temperature**



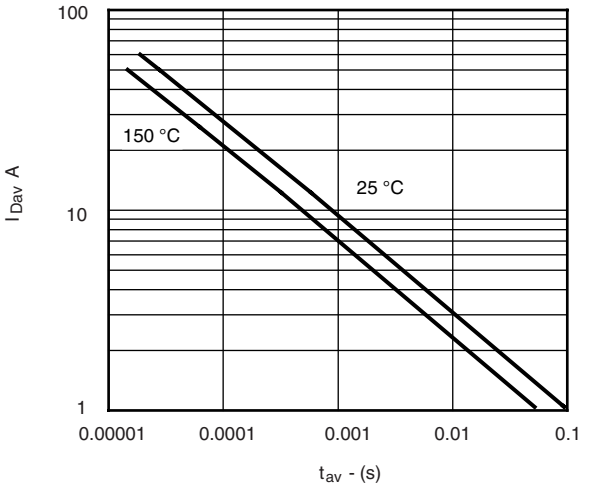

**Source-Drain Diode Forward Voltage**




**Threshold Voltage**

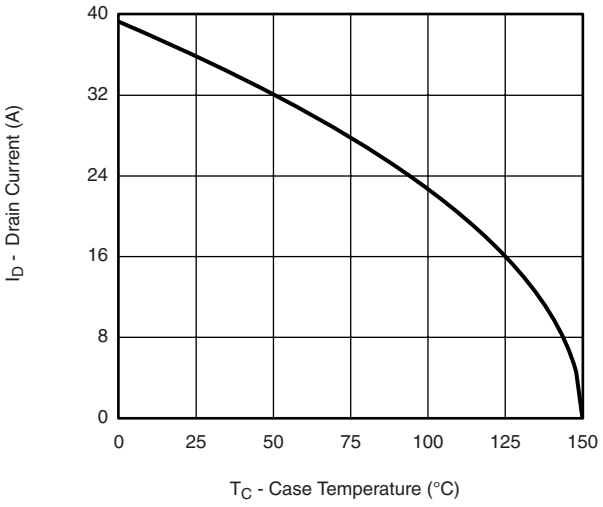



**Drain Source Breakdown vs. Junction Temperature**

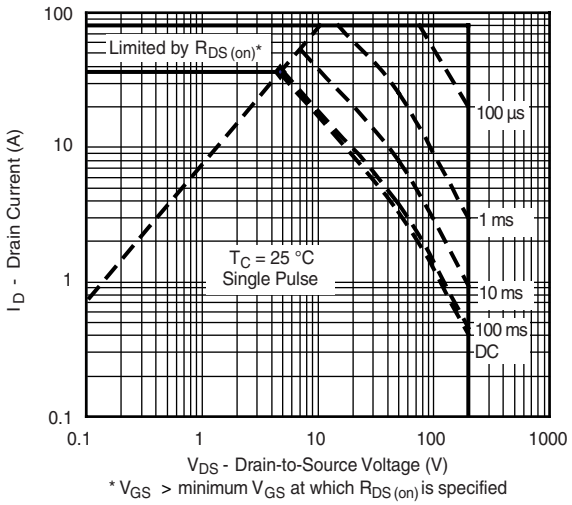



**Single Pulse Avalanche Current Capability vs. Time**

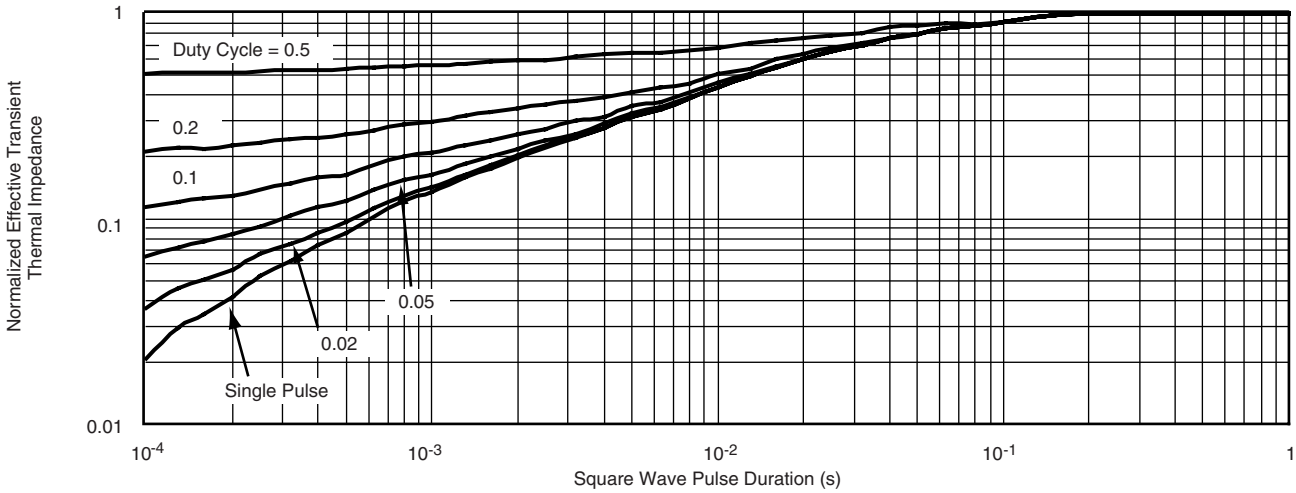
## THERMAL RATINGS




**Maximum Drain Curent vs. Case Temperature**




**Safe Operating Area**




**Normalized Thermal Transient Impedance, Junction-to-Case**

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